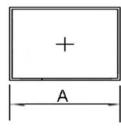


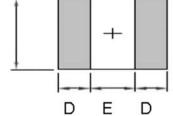
FEATRLRES

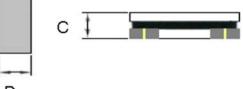
- This specification applies Low Profile Power Inductors.
- 100% Lead(Pb) & Halogen-Free and RoHS compliant.

В

CONFIGRLRATIONS & DIMENSIONS (unit in mm)







Туре	Α	В	С	D	E
HNR201610CF	2.0 -0.1/+0.2	1.6 -0.1/+0.2	1.0max.	0.60 ref.	0.80 ref.

ELECTRICAL CHARACTERISTICS

Part Number	Inductance	Tolerance	Test	DCR	I sat (A)	I sat (A)	I rms (A)	I rms (A)
Part Number	(uH)	(%)	Frequency (Hz)	(Ω) ±20%	typ.	max.	typ.	max.
HNR201610CF-R47Y	0.47	±30%	0.1V/1M	0.044	3.00	2.70	2.60	2.35
HNR201610CF-R68Y	0.68	±30%	0.1V/1M	0.062	2.45	2.00	2.25	2.05
HNR201610CF-1R0Y	1.0	±30%	0.1V/1M	0.080	1.95	1.80	1.75	1.60
HNR201610CF-1R5Y	1.5	±30%	0.1V/1M	0.130	1.65	1.46	1.40	1.26
HNR201610CF-2R2N	1 2.2	±20%	0.1V/1M	0.145	1.45	1.26	1.35	1.20
HNR201610CF-3R3N	1 3.3	±20%	0.1V/1M	0.245	1.05	0.90	1.05	0.95
HNR201610CF-4R7N	1 4.7	±20%	0.1V/1M	0.360	0.85	0.77	1.00	0.90
HNR201610CF-6R8M	1 6.8	±20%	0.1V/1M	0.500	0.80	0.72	0.70	0.55
HNR201610CF-100M	1 10	±20%	0.1V/1M	0.720	0.62	0.55	0.50	0.45
HNR201610CF-150M	1 15	±20%	0.1V/1M	1.400	0.50	0.45	0.40	0.36
HNR201610CF-180M	1 18	±20%	0.1V/1M	1.800	0.45	0.40	0.38	0.34

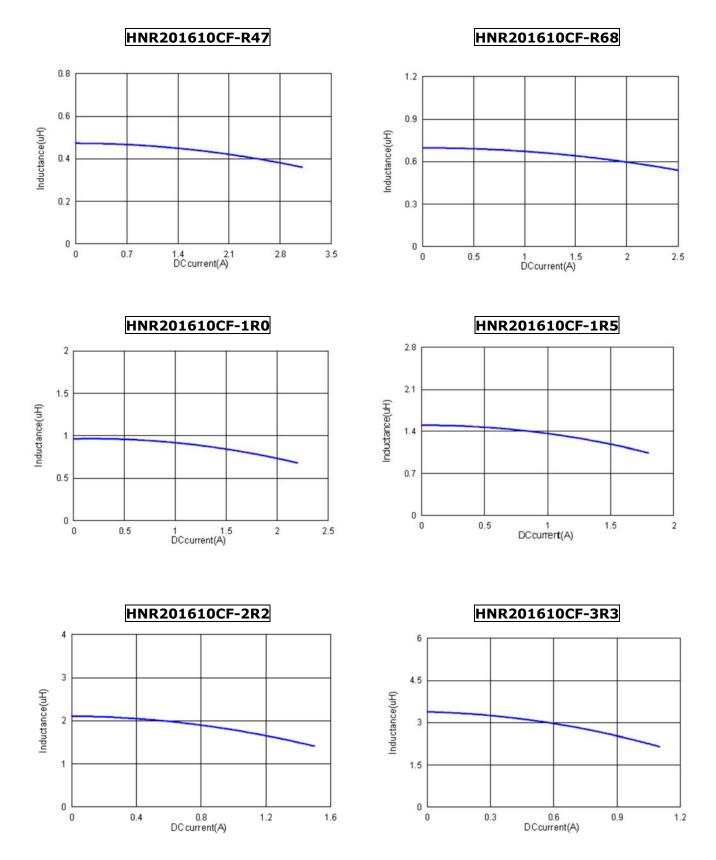
Note:

Isat : Based on inductance change $(\triangle L/L0 : \leq -30\%)$ @ ambient temp. 25° C

Irms : Based on temperature rise $(\triangle T : 40^{\circ} C \text{ typ.})$



TYPICALELECTRICALCHARACTERISTICS:







8

6

4

2

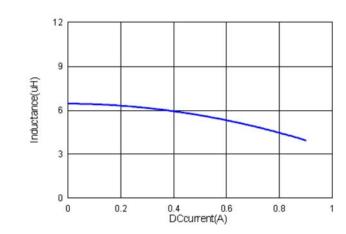
0

0

Inductance(uH)

HNR201610CF-4R7

HNR201610CF-6R8

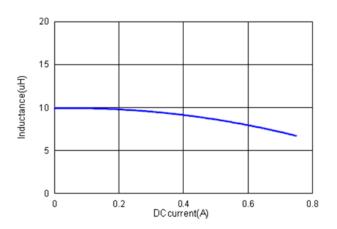


HNR201610CF-100

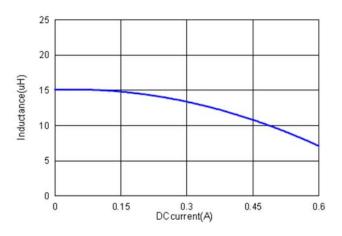
0.6 DCcurrent(A) 0.9

1.2

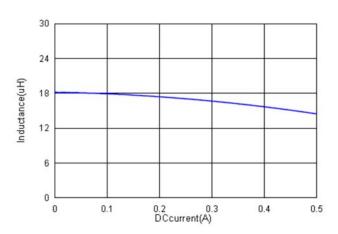
0.3



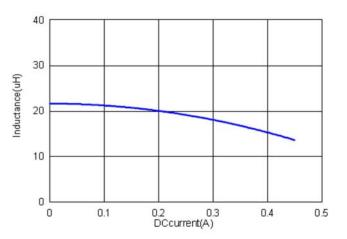
HNR201610CF-150



HNR201610CF-150



HNR201610CF-180





Reliability and Test Condition

Item	Performance	Test Condition
Operating temperature	-40~+125°C (Including self - temperature rise)	
Storage temperature	110~+40℃,50~60%RH (Product with taping) 240~+125℃(on board)	
Electrical Performance Test		
Inductance	Refer to standard electrical characteristics list.	HP4284A,CH11025,CH3302,CH1320,CH1320S LCR Meter.
DCR		CH16502, Agilent 33420A Micro-Ohm Meter.
Saturation Current (Isat)	Approximately∆L30%	Saturation DC Current (Isat) will cause L0 to drop $\ \triangle L(\%)$
Heat Rated Current (Irms)	Approximately △T40°C	Heat Rated Current (Irms) will cause the coil temperature rise $\triangle T(^{\circ}C)$. 1.Applied the allowed DC current 2.Temperature measured by digital surface thermometer
Reliability Test		
Life Test		Preconditioning: Run through IR reflow for 2 times.(IPC/JEDEC J-STD-020DClassification Reflow Profiles) Temperature : 125±2°C (Inductor) Applied current : rated current Duration : 1000±12hrs Measured at room temperature after placing for 24±2 hrs Preconditioning: Run through IR reflow for 2 times.(IPC/JEDEC
Load Humidity		J-STD-020DClassification Reflow Profiles Humidity : $85\pm 2 \times R.H$, Temperature : $85^{\circ}C \pm 2^{\circ}C$ Duration : 1000hrs Min. with 100% rated current
Moisture Resistance	Appearance : No damage. Inductance : within±10% of initial value Q : Shall not exceed the specification value. RDC : within ±15% of initial value and shall not exceed the specification value	 Preconditioning: Run through IR reflow for 2 times.(IPC/JEDEC J-STD-020DClassification Reflow Profiles 1. Baked at50°C for 25hrs, measured at room temperature after placing for 4 hrs. 2. Raise temperature to 65±2°C 90-100%RH in 2.5hrs, and keep 3 hours, cool down to 25°C in 2.5hrs. 3. Raise temperature to 65±2°C 90-100%RH in 2.5hrs, and keep 3 hours, cool down to 25°C in 2.5hrs. 4. Keep at 25°C for 2 hrs then keep at -10°C for 3 hrs 4. Keep at 25°C 80-100%RH for 15min and vibrate at the frequency of 10 to 55 Hz to 10 Hz, measure at room temperature after placing for 1~2 hrs.
Thermal shock Vibration		OldDClassification Reflow Profiles Condition for 1 cycle Step1 : -40±2°C 30±5min Step2 : 25±2°C ≤0.5min Step3 : 125±2°C 30±5min Number of cycles : 500 Measured at room temperature after placing for 24±2 hrs Oscillation Frequency: 10 ~ 2K ~ 10Hz for 20 minutes Equipment : Vibration checker
		Total Amplitude:1.52mm±10% Testing Time : 12 hours(20 minutes, 12 cycles each of 3 orientations).
Bending		Shall be mounted on a FR4 substrate of the following dimensions: >=0805 inch(2012mm):40x100x1.2mm <0805 inch(2012mm):40x100x0.8mm Bending depth: >=0805 inch(2012mm):1.2mm <0805 inch(2012mm):0.8mm duration of 10 sec.
Shock	Appearance : No damage. Impedance : within±15% of initial value Inductance : within±10% of initial value Q : Shall not exceed the specification value. RDC : within ±15% of initial value and shall not exceed the expecification value.	TypePeak value (g's)Normal duration (D)Wave formVelocity change (Vi)ft/secSMD5011Half-sine11.3
	exceed the specification value	Lead 50 11 Half-sine 11.3
Solder ability	More than 95% of the terminal electrode should be covered with solder,	Preheat: 150℃,60sec.。 Solder: Sn96.5% Ag3% Cu0.5% Temperature: 245±5℃ 。



		Flux for lead free: Rosin. 9.5% 。 Dip time: 4±1sec 。
		Depth: completely cover the termination
		Depth: completely cover the termination
Resistance to Soldering Heat		Temperature ramp/immersion and emersion rate Number of heat cycles
		260 ±5 (solder temp) 10 ±1 25mm/s ±6 mm/s 1
Terminal Strength	Appearance : No damage. Impedance : within±15% of initial value Inductance : within±10% of initial value Q : Shall not exceed the specification value. RDC : within ±15% of initial value and shall not exceed the specification value e	Preconditioning: Run through IR reflow for 2 times.(IPC/JEDEC J-STD- 020DClassification Reflow Profiles With the component mounted on a PCB with the device to be tested, apply a force/<0805:1kg, <=0805:0.5kg)to the side of a device being tested. This force shall be applied for 60 +1 seconds. Also the force shall be applied gradually as not to apply a shock to the component being tested.

Note : When there are questions concerning measurement result : measurement shall be made after 48 ± 2 hours of recovery under the standard condition.